# Notice of References Cited Notice of References Cited Application/Control No. 10/708,874 Examiner BRIAN P. YENKE Applicant(s)/Patent Under Reexamination SHAN ET AL. Art Unit Page 1 of 3

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,414,719	07-2002	Parikh, Sandip	348/448
*	В	US-6,262,773	07-2001	Westerman, Larry Alan	348/448
*	С	US-5,990,978	11-1999	Kim et al.	348/663
*	D	US-5,365,281	11-1994	Ko et al.	348/700
*	E	US-5,339,113	08-1994	Iwasaki, Kiyoshi	348/604
*	F	US-7,046,299	05-2006	Lowe, Virgil L.	348/500
*	G	US-6,278,495	08-2001	Lowe et al.	348/665
*	Н	US-6,300,985	10-2001	Lowe et al.	348/665
*	١	US-5,786,872	07-1998	Miyazaki et al.	348/669
*	J	US-5,430,500	07-1995	Hoshino et al.	348/701
*	К	US-5,285,266	02-1994	Jo, Hyun-Duk	348/665
*	L	US-6,400,762	06-2002	Takeshima, Masahiro	375/240.01
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